Issue Classification



Application/Control No.	Applicant(s)/Patent Under Reexamination							
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10576220	LEE ET AL.							
Examiner	Art Unit							
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MARCOS BATISTA	2617							
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ORIGINAL CLASS SUBCLASS						INTERNATIONAL CLASSIFICATION									
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455 466					Н	0	4	W	4 / 00 (2009.01.01)						
CROSS REFERENCE(S)															
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	Claims renumbered in the same order as presented by applicant						☐ CPA ☐ T.D. ☐ R.1.47						47		
Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original
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/MARCOS BATISTA/ Examiner, Art Unit 2617	7/1/2009	Total Claims Allowed:			
(Assistant Examiner)	(Date)				
/Rafael Pérez-Gutiérrez/ Supervisory Patent Examiner, Art Unit 2617	07/01/2009	O.G. Print Claim(s)	O.G. Print Figure		
(Primary Examiner)	(Date)	1	4		

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